## Notice of References Cited

Application/Control No. 10/785,428		Applicant(s)/Patent Under Reexamination NISHIYAMA ET AL.		
	Examiner	Art Unit		
	Avraham Lerner	3611	Page 1 of 1	

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4,765,426	08-1988	Shimizu, Yasuo	180/446
	В	US-5,764,015 A	06-1998	Shimizu et al.	318/587
	С	US-6,091,214 A	07-2000	Yamawaki et al.	318/52
	D	US-6,240,349 B1	05-2001	Nishimoto et al.	701/41
	Ε	US-6,272,410 B2	08-2001	Okanoue et al.	701/42
	F	US-6,711,484 B2	03-2004	Kifuku et al.	701/41
	G	US-6,768,283 B2	07-2004	Tanaka et al.	318/632
	Н	US-6,744,232 B2	06-2004	Endo, Shuji	318/432
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	м	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP1115771	05-1989	JP	Oe et al.	B62D 5/04
	0					
	Р					
	Q					
	R					
	s					7
	Т				7.3	

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.